## Notice of References Cited

Application/Control No.

10/100,398

Applicant(s)/Patent Under Reexamination AMICHE ET AL.

Examiner

Ellen E Kim

Applicant(s)/Patent Under Reexamination AMICHE ET AL.

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**U.S. PATENT DOCUMENTS** 

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,841,929 /	11-1998	Komatsu et al.	385/129
	В	US-6,236,784 /	05-2001	Ido, Tatemi	385/45
	С	US-5,333,219	07-1994	Kuznetsov, Mark E.	385/45
	D	US-5,091,986	02-1992	Arii et al.	385/48
	Е	US-5,838,853	11-1998	Jinnai et al.	385/50
	F	US-5,058,978	10-1991	Kondoh et al.	385/43
	G	US-5,946,434	08-1999	Lee, Hyung-Jae	385/45
	Н	US-5,570,442	10-1996	Arii et al.	385/46
	ı	US-5,949,931	09-1999	Kitamura, Naoki	385/28
	J	US-5,410,625	04-1995	Jenkins et al.	385/28
	κ	US-5,586,209 /	12-1996	Matsuura et al.	385/45
	Ļ	US-			
Ţ	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
<u> </u>	N-					
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## NON-PATENT DOCUMENTS

Γ.	TOTAL ATENT DOCUMENTS					
*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	x					
'A cor	ov of thi	S reference is not being furnished with this Office action (O. NOTE)				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.